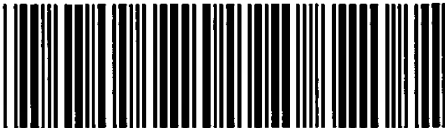


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/758,373	TANABE ET AL.	
	Examiner	Art Unit	
	SHIBRU HELEN	2616	

SEARCHED			
Class	Subclass	Date	Examiner
386	46, 125-126,95	12/21/2004	HS
369	53.2,30	12/22/2004	HS

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Thai Tran	12/20/2004	386
Tan Dinh	12/22/2004	369
Vu, NgocYen	12/23/2004	369